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Substitute for form 1449A/B/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)				Complete if Known	
				Application Number	Unassigned
				Filing Date	September 16, 2003
				First Named Inventor	Koji KISE
				Group Art Unit	Unassigned
				Examiner Name	Unassigned
Sheet	1	of	1	Attorney Docket Number	402786/FUKAMI

U.S. PATENT DOCUMENTS						
Examiner Initials	Doc. No.	U.S. Patent Document		Name of Patentee or Applicant	Date of Publication	Filing Date If Appropriate
		Application or Patent Number	Kind Code			
CEL	A 1	2002/0196896		Kitayama et al.	12/26/2002	
CEL	A 2	2003/0099324		Itoaga et al.	5/29/2003	
CEL	A 3	2003/0152190		Watanabe et al.	8/14/2003	

OTHER - NON PATENT LITERATURE DOCUMENTS				
Examiner Initials	Doc. No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number (s), publisher, city and/or country where published.	Translation	
			Yes	No**
CEL	A 4	T. TAKIGAWA, "The Innovation of ULSI Lithography" Science Forum Co. Ltd., 1995, pp. 222, 1 st edition. <i>unable to evaluate foreign language</i>		
CEL	A 5	KISE et al., "Suppression of Secodary Electron Blur By Using Br-Containing Resists In X-Ray Lithography", <i>Journal of Vacuum Science & Tech. B., The Society Through the American Institute of Physics</i> , 2002, pp. 2953-2957, 20(6.)		
CEL	A 6	K. ITOGA et al., "Effect of Secondary Electron from the Substrate In X-Ray Lithography Using Harder Radiation Spectra", <i>Journal of Vacuum Science & Tech. B., The Society Through the American Institute of Physics</i> , 2001, pp. 2439-2443, 19(6).		

Examiner Signature	<i>Chun</i>	Date Considered	3/05
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* A concise statement of relevance is being submitted in lieu of a translation. 37 CFR 1.98(a)(3).
 + An English-language equivalent/patent, or an English-language abstract, or an English-language version of the search report or action by a foreign patent office in a counterpart foreign application indicating the degree of relevance found by the foreign office is being submitted in lieu of a concise explanation of relevance under 37 CFR 1.98(a)(3).